Review of CRT Changes

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August 17, 2007, Plenary Meeting

CRT Finalization Issue Log
(issues with pre-final drafts from the subcommittees and voting@nist.gov)

• 282 logged issues as of 2007-08-08
  – 225 addressed
  – 30 forwarded to STS, project manager, or editorial team
  – 15 marked as duplicates
  – 3 out of scope
  – 3 de minimis (revisit if time permits)
  – 3 unclear
  – 1 open
  – 1 confirmed (fix if a good solution is proposed)
  – 1 conflicting
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Highlights of Resolved Issues

• Missing shake & bake tests: no longer missing
• Benchmarking test method: rewrote explanation
• Frequently misconstrued terms: replaced with more explanatory wording
• Software engineering practices: fixed nits
• Volume test: more parameters for op-scan

• Many requirements clarified through wording changes or defined terms
To do

• Open: “define token” (wants STS input)
• Pending: nits in text rendering of process model
  – Typo
  – Harmonize with Activity Diagram Linear Form
• Revisit *de minimis* and confirmed issues